

40V 1.05mohm N-channel SGT MOSFET
AKG4N010GM-A

Description:

This device is designed for automotive applications and manufactured in IATF16949 certified facilities. Qualified AEC-Q101, PPAP capable.

Features:

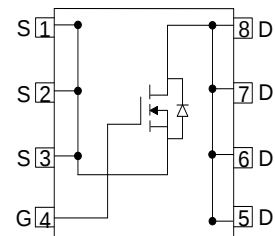
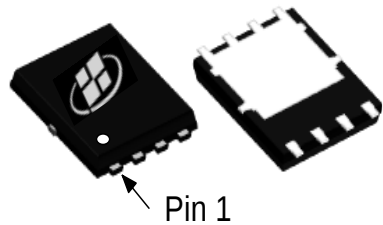
- Low $R_{DS(ON)}$
- 100% UIS Tested
- RoHS compliant
- Halogen-free
- AEC-Q101 Qualified and PPAP capable

Applications:

- Battery Management System
- Motor Drivers
- DC-DC Converter

Key Performance Parameters:

Parameter	Value	Unit
V_{DS}	40	V
$R_{DS(ON), max} @V_{GS} = 10\text{ V}$	1.05	m Ω
I_D	250	A



Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKG4N010GM-A	PDFN5X6	G4N010GM	Tape Reel	5000PCS

Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{DS}	Drain-Source Voltage	40	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$) ^(Note 1)	250	A
	Drain Current - Continuous ($T_C = 100^\circ\text{C}$)	177	A
I_{DM}	Drain Current - Pulsed ^(Note 2)	1000	A
V_{GS}	Gate-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy ^(Note 3)	625	mJ
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	125	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +175	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Steady-State	1.2	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Steady State ^(Note 4)	45	$^\circ\text{C/W}$

Notes:

1. The max drain current rating is silicon limited
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $L = 0.5 \text{ mH}$, $V_{DD} = 40 \text{ V}$, $I_{AS} = 50 \text{ A}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$
4. Mount on minimum PCB layout

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	40			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 40 V, V _{GS} = 0 V			1	μA
		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 125 °C			100	μA
I _{GSS}	Gate Leakage Current	V _{GS} = ± 20 V, V _{DS} = 0 V			± 100	nA
V _{GS(TH)}	Gate Threshold voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.5	3	3.5	V
R _{DS(ON)}	Drain-Source on-state resistance	V _{GS} = 10 V, I _D = 50 A		0.8	1.05	mΩ
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, F = 1 MHz		5810		pF
C _{OSS}	Output Capacitance			1640		pF
C _{RSS}	Reverse Transfer Capacitance			15		pF
R _g	Gate Resistance	F = 1 MHz		4.7		Ω
Switching Characteristics						
T _{D(ON)}	Turn On Delay Time	V _{DD} = 20 V , R _L = 0.4 Ω, V _{GS} = 10 V, R _G = 2.5 Ω		15		nS
T _R	Rise Time			50		nS
T _{D(OFF)}	Turn Off Delay Time			65		nS
T _F	Fall Time			45		nS
Q _G	Total Gate Charge	V _{DD} = 20 V , I _D = 50 A, V _{GS} = 10 V		72		nC
Q _{GS}	Gate-Source Charge			30		nC
Q _{GD}	Gate-Drain Charge			14		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Body-Diode Forward Current				250	A
I _{SM}	Maximum Pulsed Body-Diode Forward Current				1000	A
V _{SD}	Diode Forward Voltage	V _{GS} = 0 V, I _S = 50 A		0.8	1.2	V
T _{RR}	Reverse recovery time	V _{DD} = 20 V, I _D = 50 A, di/dt = 100 A/μS		75		nS
Q _{RR}	Reverse recovery charge			150		nC
I _{RRM}	Peak Reverse Recovery Current			3		A

Electrical Characteristics Diagrams

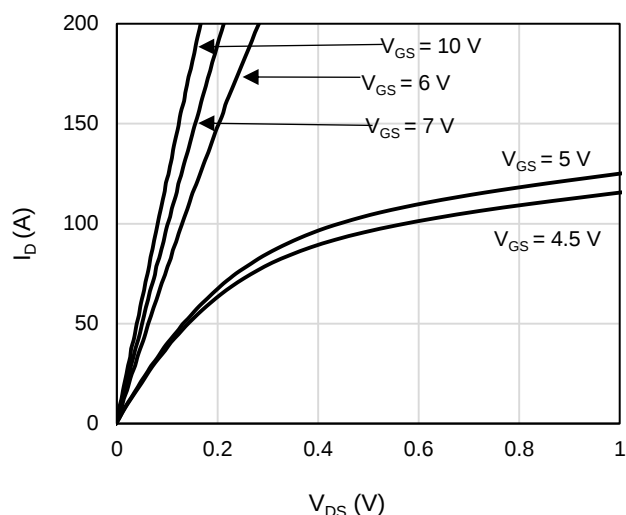


Figure 1: On-Region Characteristics

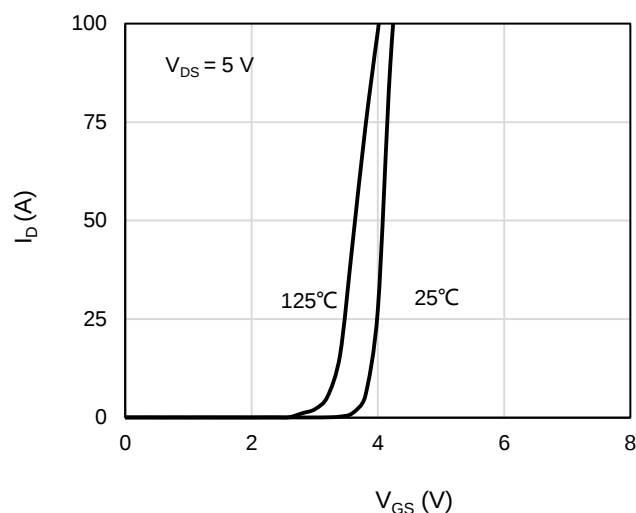


Figure 2: Transfer Characteristics

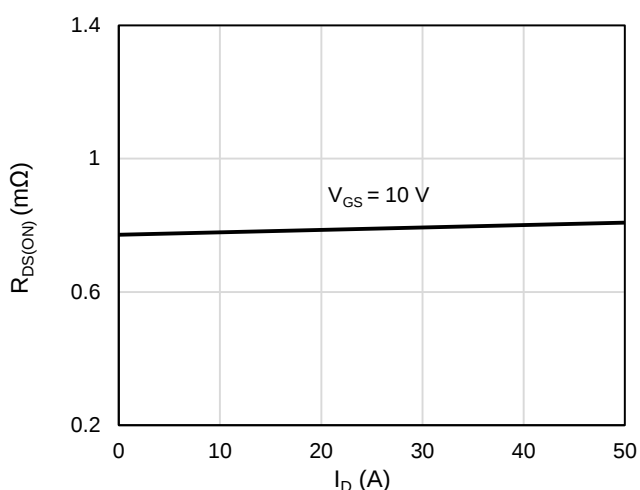


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

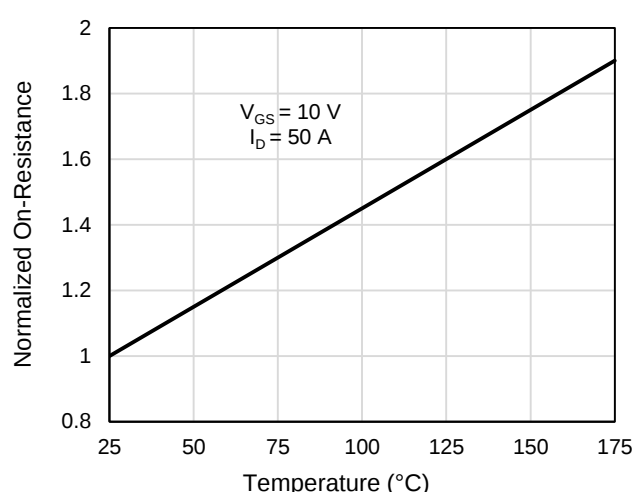


Figure 4: On-Resistance vs. Junction Temperature

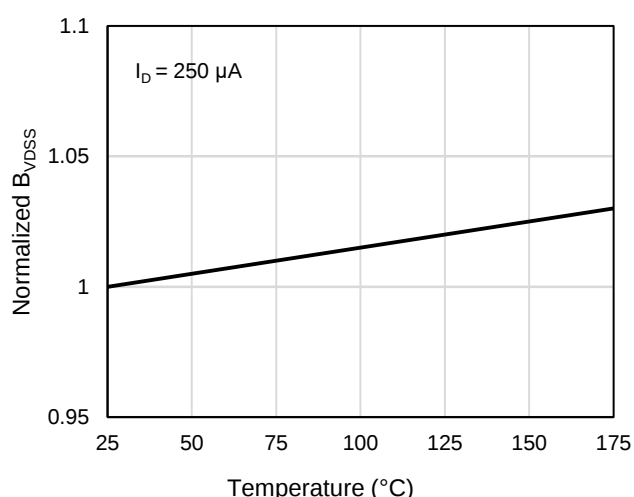


Figure 5: Breakdown Voltage vs. Junction Temperature

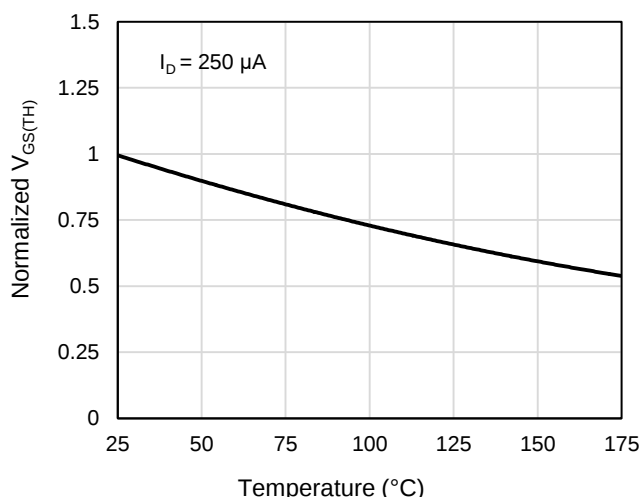
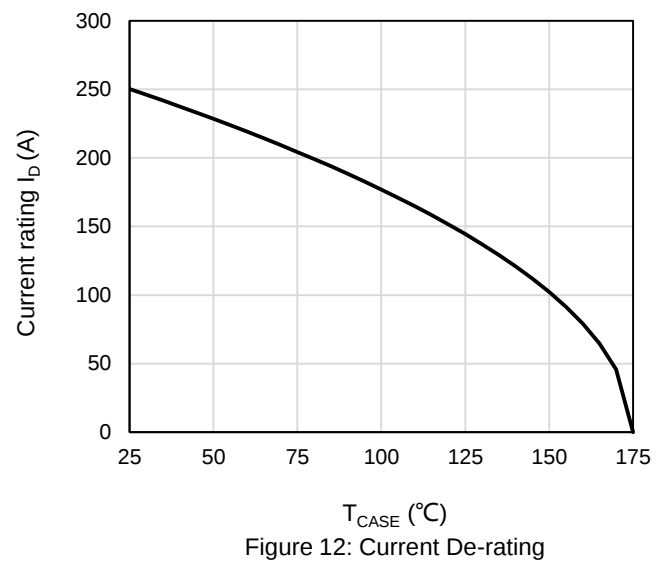
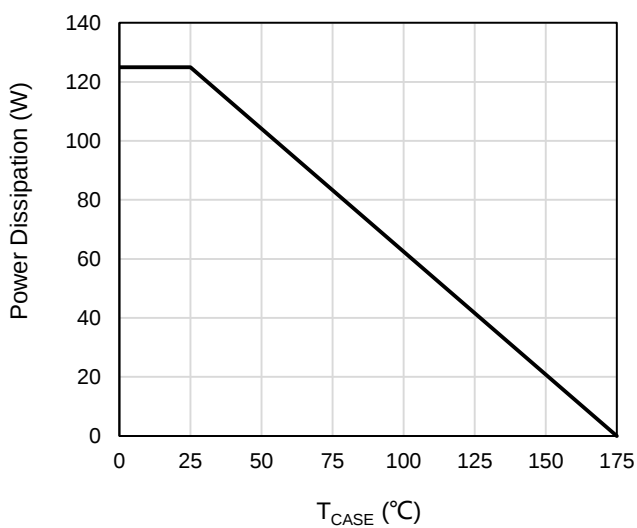
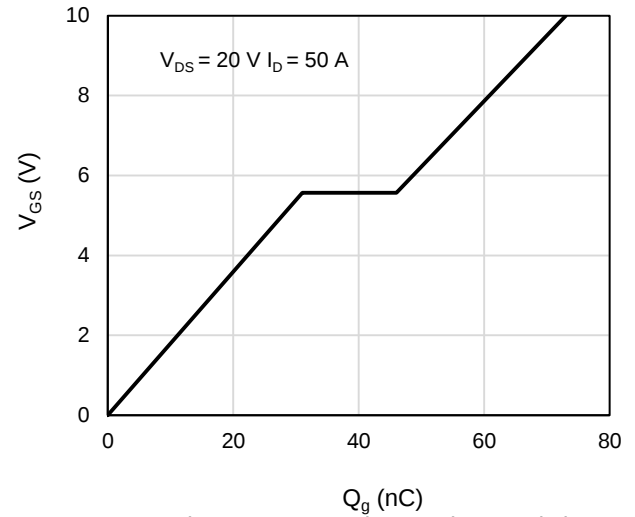
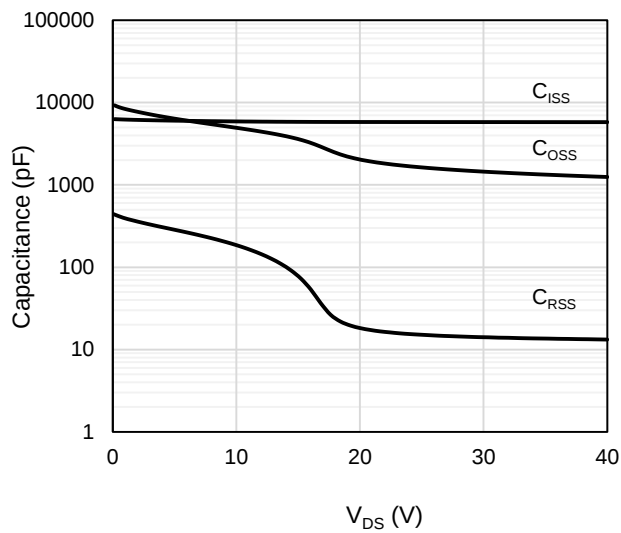
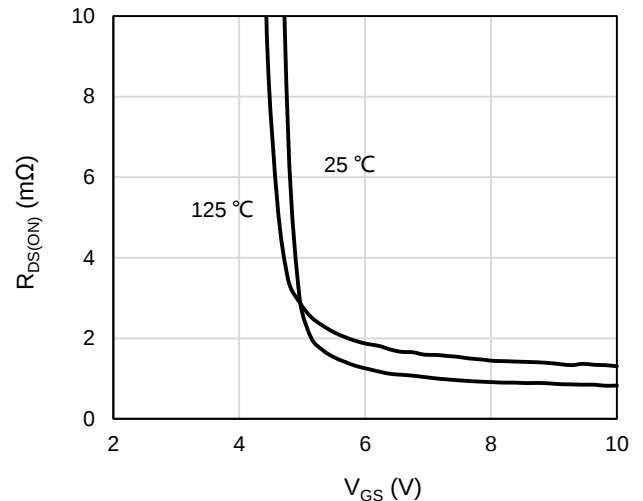
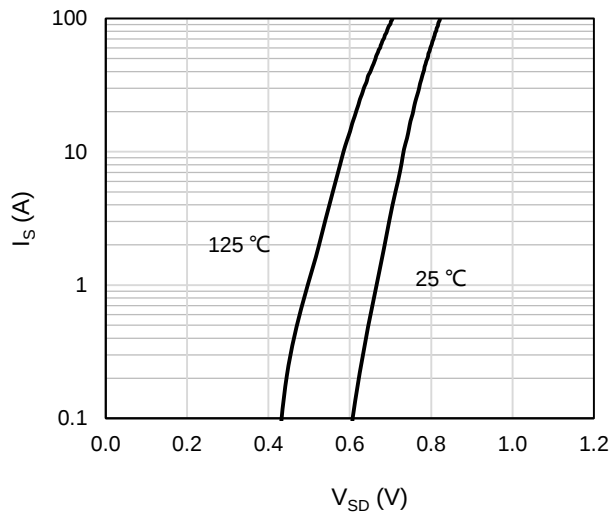
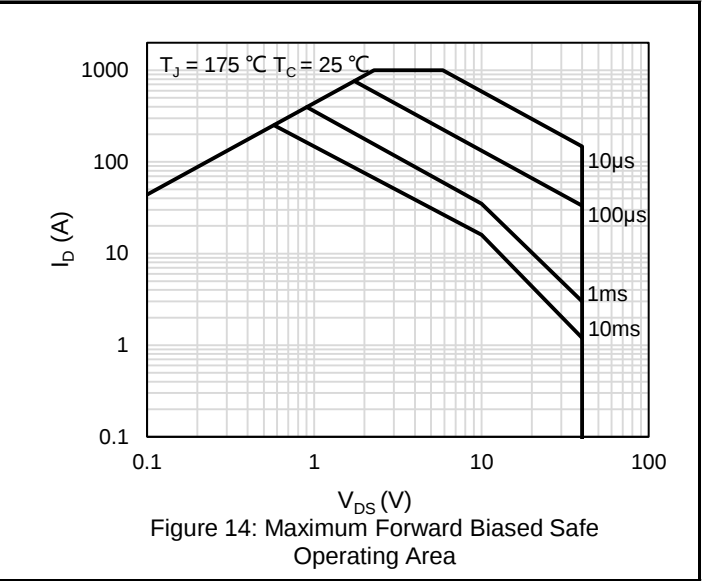
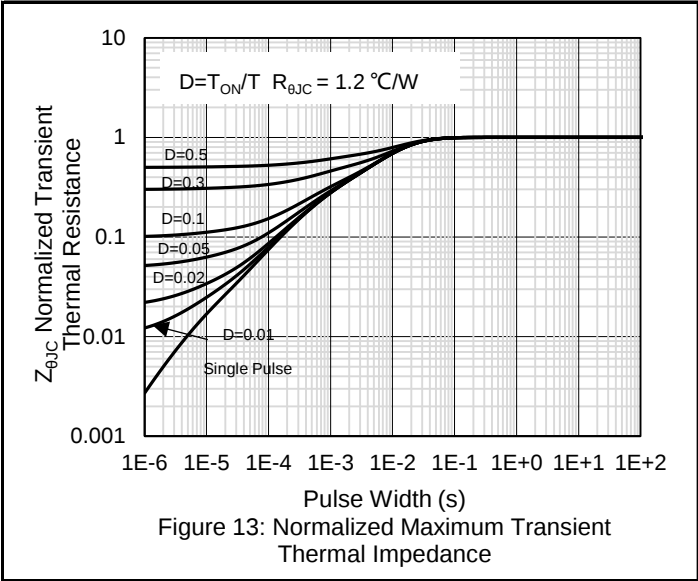


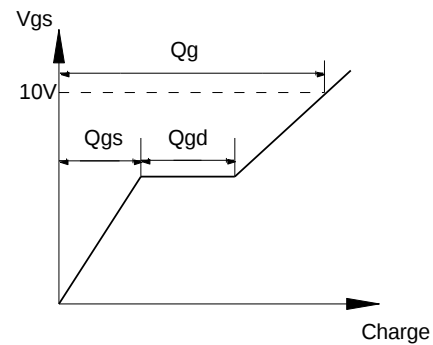
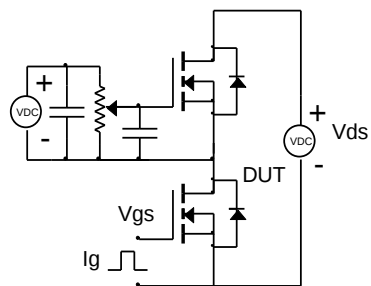
Figure 6: Threshold Voltage vs. Junction Temperature



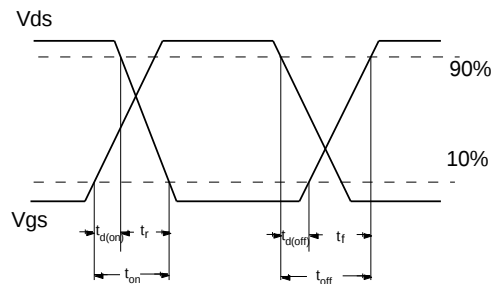
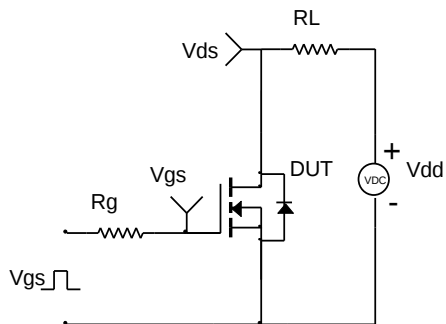


Test Circuit and Waveform

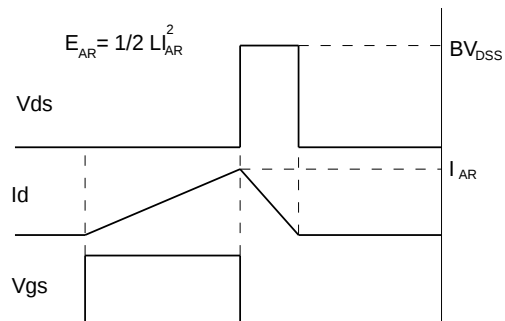
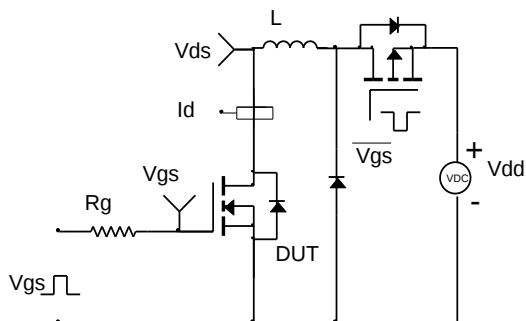
Gate Charge Test Circuit & Waveform



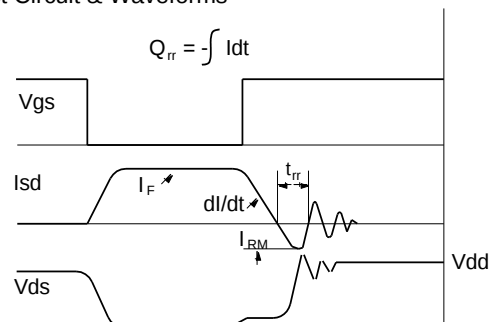
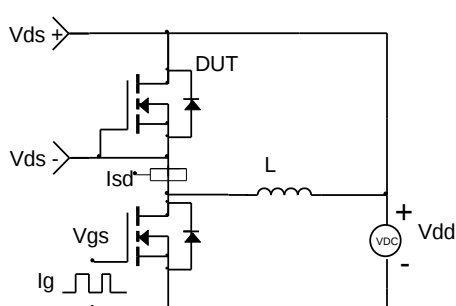
Resistive Switching Test Circuit & Waveforms



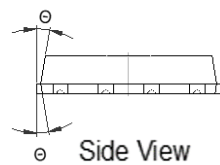
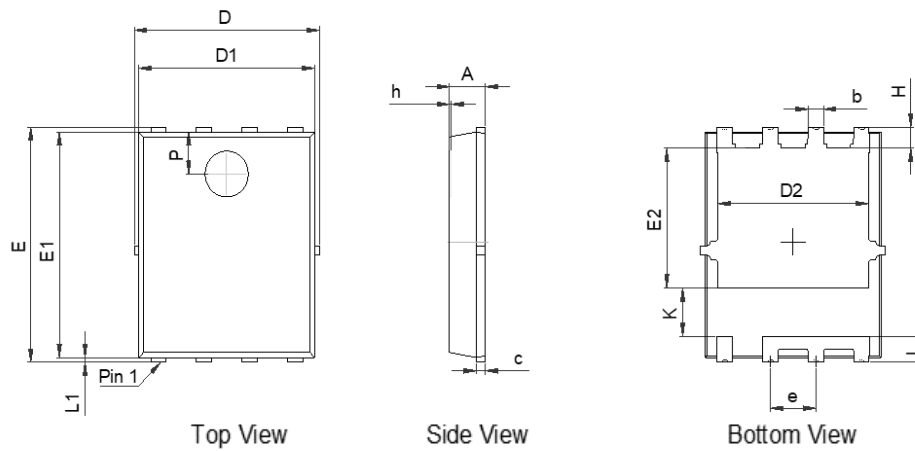
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



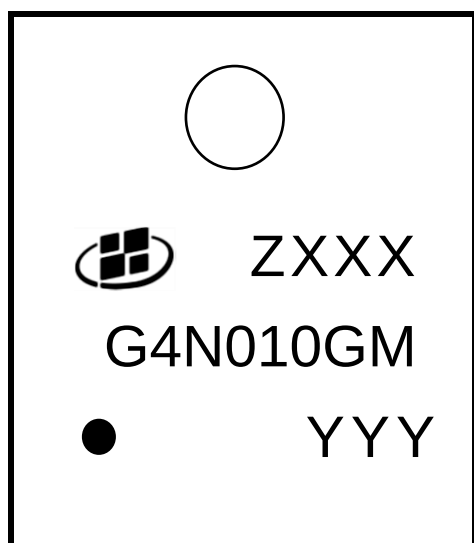
Package Outlines



SYMBOL	MIN	NOM	MAX
A	0.90	1.00	1.10
b	0.32	0.42	0.52
c	0.21	0.25	0.34
D	5.00	5.15	5.30
D1	4.80	4.90	5.00
D2	4.10	4.20	4.30
e	1.27BSC		
E	6.00	6.15	6.30
E1	5.80	5.90	6.00
E2	3.55	3.65	3.75
H	0.45	0.55	0.65
h	—	—	0.10
K	1.22	—	—
L	0.535	0.635	0.735
L1	0.05	0.13	0.21
Θ	8°	10°	12°
P	1.05	1.10	1.15

Unit in mm

Marking Information



Note:

G4N010GM = Product Name Code

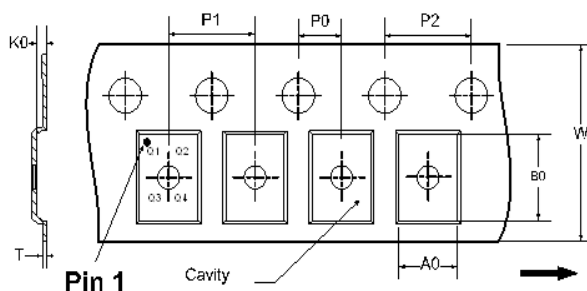
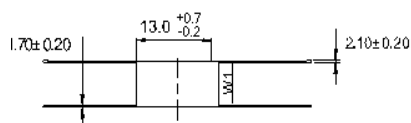
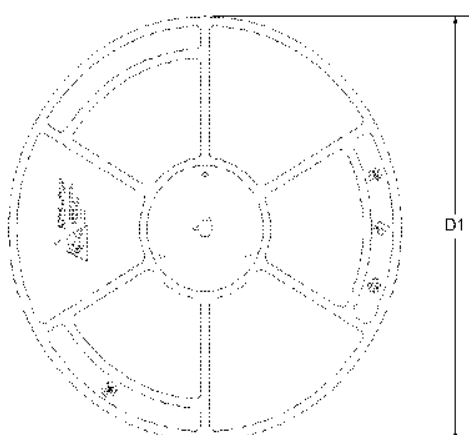
ZXXX = Date code

YYY

Contact ALKAIDSEMI sales for detail information

Tape & Reel Information

REEL DIMENSIONS



A0: Dimension designed to accommodate the component width
 B0: Dimension designed to accommodate the component length
 K0: Dimension designed to accommodate the component thickness
 W: Overall width of the carrier tape
 P0: Pitch between successive cavity centers and sprocket hole
 P1: Pitch between successive cavity centers
 P2: Pitch between sprocket hole
 T: Tape material thickness
 D1: Reel Diameter
 W1: Reel Width

DIMENSIONS (Unit:mm)										
Reel	D1	W1								Material
	330	12.4								Hips
Tape	P0	P1	P2	W	A0	B0	K0	T	Pin 1 Quadrant	Material
	2	8	4	12	6.45	5.45	1.2	0.25	Q1	PC

Revision History

Revision	Release Date	Remark
Rev.1.1	2023/7/25	

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.